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WeEn Semiconductors





### 1. General description

Planar passivated sensitive gate four quadrant triac in a SOT404 (D2PAK) surfacemountable plastic package intended for use in general purpose bidirectional switching and phase control applications. This sensitive gate "series E" triac is intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

### 2. Features and benefits

- Direct triggering from low power drivers and logic ICs
- High blocking voltage capability
- · Planar passivated for voltage ruggedness and reliability
- Sensitive gate
- Surface-mountable package
- Triggering in all four quadrants

### 3. Applications

- General purpose phase control
- General purpose switching

### 4. Quick reference data

•

| Symbol              | Parameter                                | Conditions  | Min | Тур | Max | Unit |
|---------------------|--|---|-----|-----|-----|------|
| V <sub>DRM</sub>    | repetitive peak off-<br>state voltage    |   | -   | -   | 800 | V    |
| I <sub>TSM</sub>    | non-repetitive peak on-<br>state current | full sine wave; $T_{j(init)} = 25 \text{ °C};$<br>$t_p = 20 \text{ ms}; \text{ Fig. 4; Fig. 5}$             | -   | -   | 155 | A    |
| I <sub>T(RMS)</sub> | RMS on-state current                     | full sine wave; T <sub>mb</sub> ≤ 99 °C; <u>Fig. 1;</u><br><u>Fig. 2; Fig. 3</u>                            | -   | -   | 16  | A    |
| Static chara        | cteristics                               |   |     |     |     |      |
| I <sub>GT</sub>     | gate trigger current                     | $V_D = 12 \text{ V}; \text{ I}_T = 0.1 \text{ A}; \text{ T2+ G+};$<br>$T_j = 25 \text{ °C}; \text{ Fig. 7}$ | -   | 2.5 | 10  | mA   |
|                     |  | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 7</u>             | -   | 4   | 10  | mA   |





# BT139B-800E

#### 4Q Triac

| Symbol | Parameter | Conditions  | Min | Тур | Max | Unit |
|--------|-----------|---|-----|-----|-----|------|
|        |           | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ T2- G-};$<br>$T_j = 25 \text{ °C}; Fig. 7$     | -   | 5   | 10  | mA   |
|        |           | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 7</u> | -   | 11  | 25  | mA   |

# 5. Pinning information

| Table 2. | Pinning | information                       |                    |                |
|----------|---------|-----------------------------------|--------------------|----------------|
| Pin      | Symbol  | Description                       | Simplified outline | Graphic symbol |
| 1        | T1      | main terminal 1                   | mb                 | T2             |
| 2        | T2      | main terminal 2                   |                    | sym051         |
| 3        | G       | gate                              |                    |                |
| mb       | T2      | mounting base; main<br>terminal 2 |                    |                |
|          |         |                                   | D2PAK (SOT404)     |                |

# 6. Ordering information

| Table 3. Ordering inf | ormation |  |         |  |  |  |
|-----------------------|----------|--|---------|--|--|--|
| Type number           | Package  |  |         |  |  |  |
|                       | Name     | Description  | Version |  |  |  |
| BT139B-800E           | D2PAK    | plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped) | SOT404  |  |  |  |

4Q Triac

## 7. Limiting values

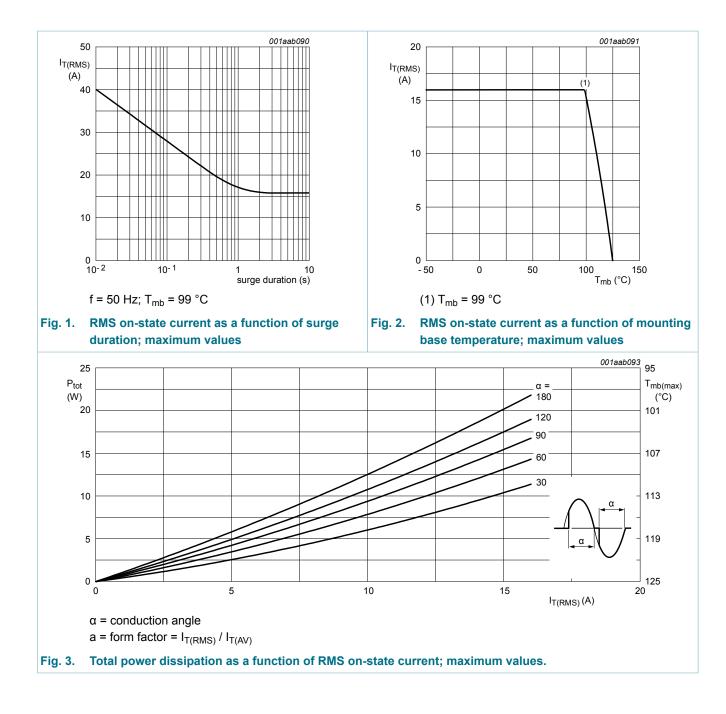
#### Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol              | Parameter                            | Conditions  | Min | Max | Unit             |
|---------------------|--------------------------------------|---|-----|-----|------------------|
| V <sub>DRM</sub>    | repetitive peak off-state voltage    |   | -   | 800 | V                |
| I <sub>T(RMS)</sub> | RMS on-state current                 | full sine wave; $T_{mb} \le 99$ °C; Fig. 1;<br>Fig. 2; Fig. 3                           | -   | 16  | A                |
| I <sub>TSM</sub>    | non-repetitive peak on-state current | full sine wave; $T_{j(init)} = 25 \text{ °C};$<br>$t_p = 20 \text{ ms}; Fig. 4; Fig. 5$ | -   | 155 | A                |
|                     |                                      | full sine wave; $T_{j(init)}$ = 25 °C;<br>$t_p$ = 16.7 ms                               | -   | 170 | A                |
| l <sup>2</sup> t    | I2t for fusing                       | t <sub>p</sub> = 10 ms; SIN   | -   | 120 | A <sup>2</sup> s |
| dI <sub>T</sub> /dt | rate of rise of on-state current     | $I_T$ = 20 A; $I_G$ = 0.2 A; $dI_G/dt$ = 0.2 A/µs;<br>T2+ G+                            | -   | 50  | A/µs             |
|                     |                                      | $I_T$ = 20 A; $I_G$ = 0.2 A; $dI_G/dt$ = 0.2 A/µs;<br>T2+ G-                            | -   | 50  | A/µs             |
|                     |                                      | $I_T$ = 20 A; $I_G$ = 0.2 A; $dI_G/dt$ = 0.2 A/µs;<br>T2- G-                            | -   | 50  | A/µs             |
|                     |                                      | $I_T$ = 20 A; $I_G$ = 0.2 A; $dI_G/dt$ = 0.2 A/µs;<br>T2- G+                            | -   | 10  | A/µs             |
| I <sub>GM</sub>     | peak gate current                    |   | -   | 2   | А                |
| P <sub>GM</sub>     | peak gate power                      |   | -   | 5   | W                |
| P <sub>G(AV)</sub>  | average gate power                   | over any 20 ms period   | -   | 0.5 | W                |
| T <sub>stg</sub>    | storage temperature                  |   | -40 | 150 | °C               |
| Tj                  | junction temperature                 |   | -   | 125 | °C               |

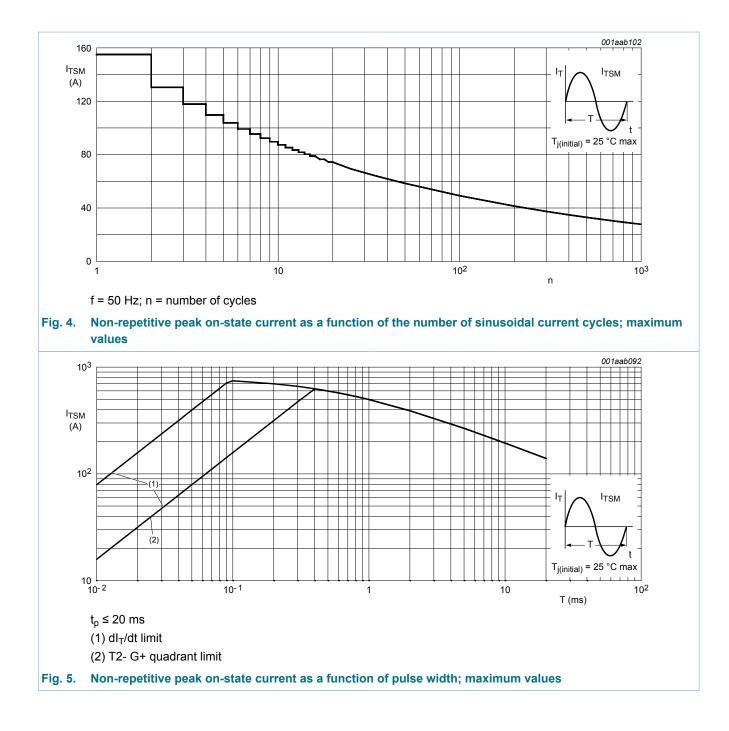
# BT139B-800E

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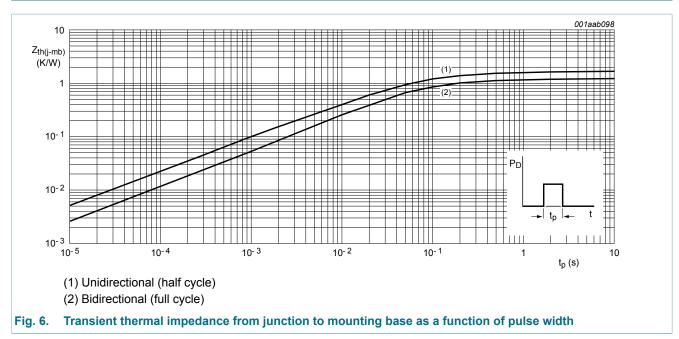
#### 4Q Triac



4Q Triac

### 8. Thermal characteristics

| Table 5. T            | hermal characteristics                            |                              |     |     |     |      |
|-----------------------|---|------------------------------|-----|-----|-----|------|
| Symbol                | Parameter   | Conditions                   | Min | Тур | Мах | Unit |
| R <sub>th(j-mb)</sub> | thermal resistance                                | half cycle; Fig. 6           | -   | -   | 1.7 | K/W  |
|                       | from junction to mounting base                    | full cycle; Fig. 6           | -   | -   | 1.2 | K/W  |
| R <sub>th(j-a)</sub>  | thermal resistance<br>from junction to<br>ambient | minimum footprint; FR4 board | -   | 55  | -   | K/W  |



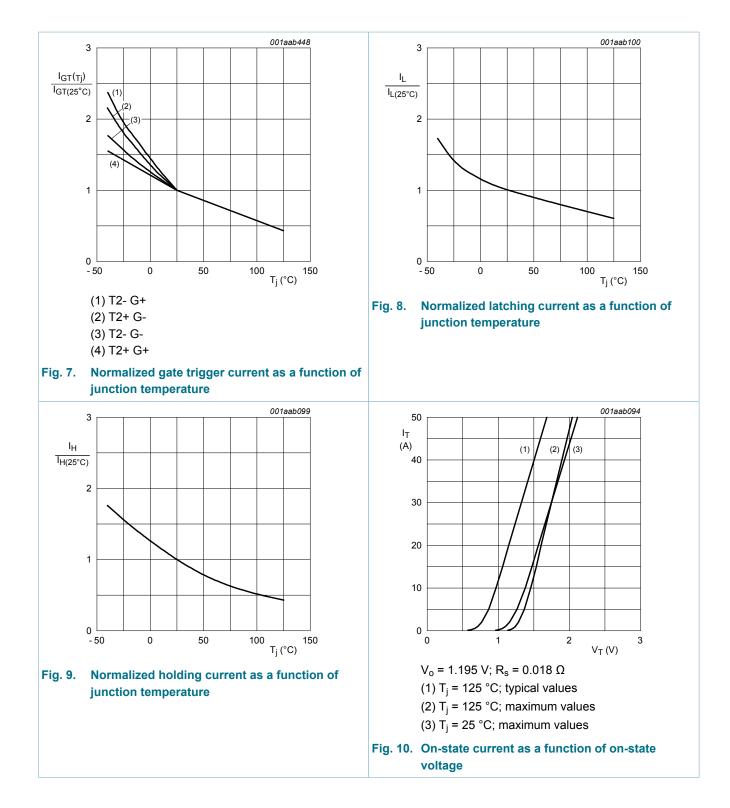
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### 9. Characteristics

| Symbol              | Parameter                         | Conditions   | Min  | Тур | Max | Unit |
|---------------------|-----------------------------------|--|------|-----|-----|------|
| Static chara        | acteristics                       | · · · · · · · · · · · · · · · · · · ·  |      |     |     |      |
| I <sub>GT</sub>     | gate trigger current              | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ T2+ G+};$<br>$T_j = 25 \text{ °C}; \frac{\text{Fig. 7}}{2}$                     | -    | 2.5 | 10  | mA   |
|                     |                                   | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 7</u>                                  | -    | 4   | 10  | mA   |
|                     |                                   | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 7</u>                                  | -    | 5   | 10  | mA   |
|                     |                                   | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 7</u>                                  | -    | 11  | 25  | mA   |
| ΙL                  | latching current                  | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2+ G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 8</u>                                  | -    | 3.2 | 30  | mA   |
|                     |                                   | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 8</u>                                  | -    | 16  | 40  | mA   |
|                     |                                   | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2- G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 8</u>                                  | -    | 4   | 30  | mA   |
|                     |                                   | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2- G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 8</u>                                  | -    | 5.5 | 40  | mA   |
| н                   | holding current                   | V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>   | -    | 4   | 45  | mA   |
| / <sub>T</sub>      | on-state voltage                  | I <sub>T</sub> = 20 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>  | -    | 1.2 | 1.6 | V    |
| / <sub>GT</sub>     | gate trigger voltage              | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C;<br>Fig. 11  | -    | 0.7 | 1   | V    |
|                     |                                   | V <sub>D</sub> = 400 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 125 °C;<br>Fig. 11  | 0.25 | 0.4 | -   | V    |
| D                   | off-state current                 | V <sub>D</sub> = 800 V; T <sub>j</sub> = 125 °C  | -    | 0.1 | 0.5 | mA   |
| Dynamic cł          | naracteristics                    | · · · · · · · · · · · · · · · · · · ·  |      |     |     |      |
| dV <sub>D</sub> /dt | rate of rise of off-state voltage | $V_{DM}$ = 536 V; T <sub>j</sub> = 125 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit | -    | 50  | -   | V/µs |
| lgt                 | gate-controlled turn-on time      | I <sub>TM</sub> = 20 A; V <sub>D</sub> = 800 V; I <sub>G</sub> = 0.1 A; dI <sub>G</sub> /<br>dt = 5 A/µs                         | -    | 2   | -   | μs   |

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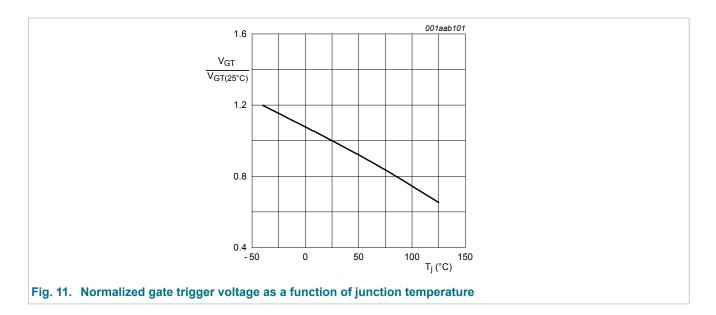


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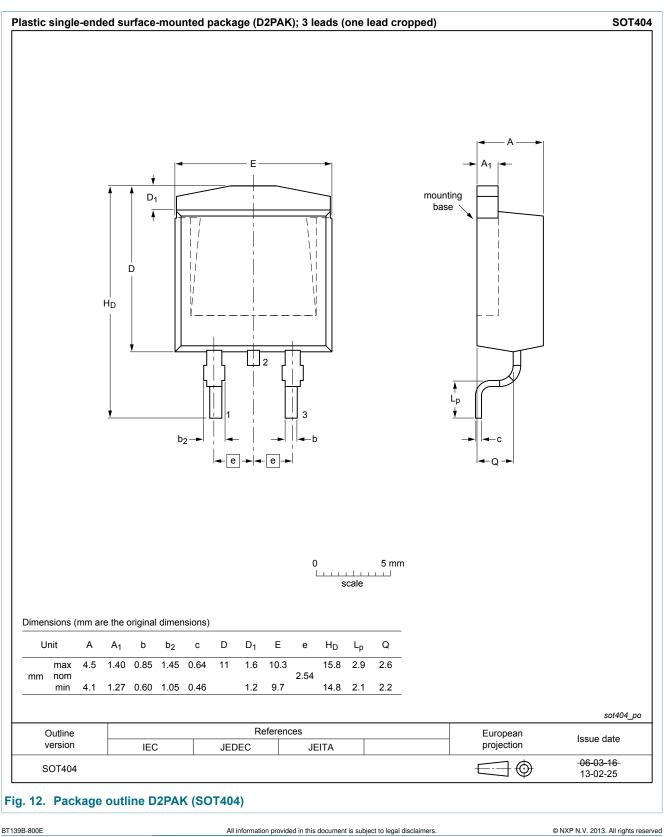


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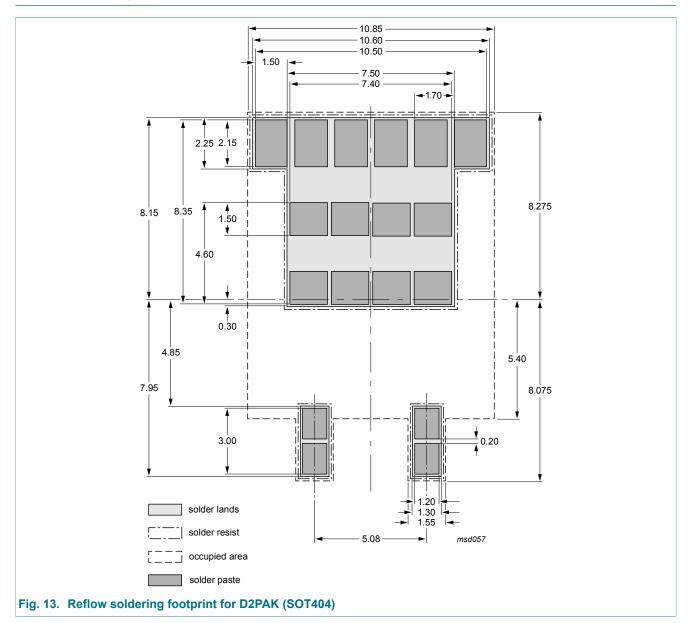
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### 10. Package outline



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# 11. Soldering



#### **4Q Triac**

### 12. Legal information

#### 12.1 Data sheet status

| Document status [1][2]               | Product<br>status [3] | Definition  |
|--------------------------------------|-----------------------|---|
| Objective<br>[short] data<br>sheet   | Development           | This document contains data from<br>the objective specification for product<br>development. |
| Preliminary<br>[short] data<br>sheet | Qualification         | This document contains data from the preliminary specification.                             |
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Product data sheet

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